

Prehod nabitih delcev in fotonov skozi snov

I. Prehod nabitih delcev

- Interakcija delec - snov
- Energijske izgube težkih nabitih delcev
- Energijske izgube elektronov in pozitronov
- Večkratno sipanje
- Energijsko stresanje
- Energijske izgube visokoenergijskih mioonov

II. Prehod fotonov

- Fotoefekt
- Comptonusko sipanje
- Tvorba parov

III. EM plaz

Literatura:

W. Leo : Techniques for Nuclear and Particle

K. Kleinknecht : Detectors for Particle Radiation

T. Ferbel : Experimental Techniques in HEP

W. Heitler : The Quantum Theory of Radiation

Particle Data Group : Review of Particle Properties, 1996
 + MX2 → 2008

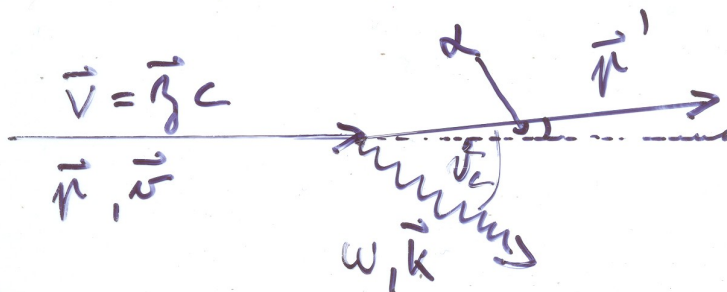
I Prehod nabitih delcev

a) interakcija delec - snov

delec : $M, p, \vec{p} = \frac{\hbar \vec{k}}{c}$

snov : $\epsilon(\omega) = \epsilon_1(\omega) + i\epsilon_2(\omega)$

$$\omega^2 = \frac{k^2 c^2}{\epsilon} \quad (1)$$



$$\vec{p} = \vec{p}' + \hbar \vec{k}$$
$$E = E' + \hbar \omega$$

$$\hbar k \ll p$$

$$\hbar \omega \ll E : \hbar \omega = \Delta E = \frac{\hbar \Delta p}{E} = v \Delta p$$

$$\vec{p} - \vec{p}' = \Delta \vec{p} = \hbar \vec{k} \quad | \cdot \vec{v} \Rightarrow (\vec{p} - \vec{p}') \cdot \vec{v} = p v - p' v \cos \theta$$

$$\Rightarrow \hbar \epsilon \cdot \vec{v} = \hbar \omega$$

$$\approx v \Delta p$$

(2 << 1)

$$\omega = 2 v \cos \theta v_c \quad (2)$$

iz (1) in (2)

$$\frac{c^2}{\epsilon} = v^2 \cos^2 \theta v_c$$

$$\sqrt{\epsilon} \frac{v}{c} \cos \theta v_c = 1 \quad (3)$$

Odnosnost $\epsilon(\omega)$

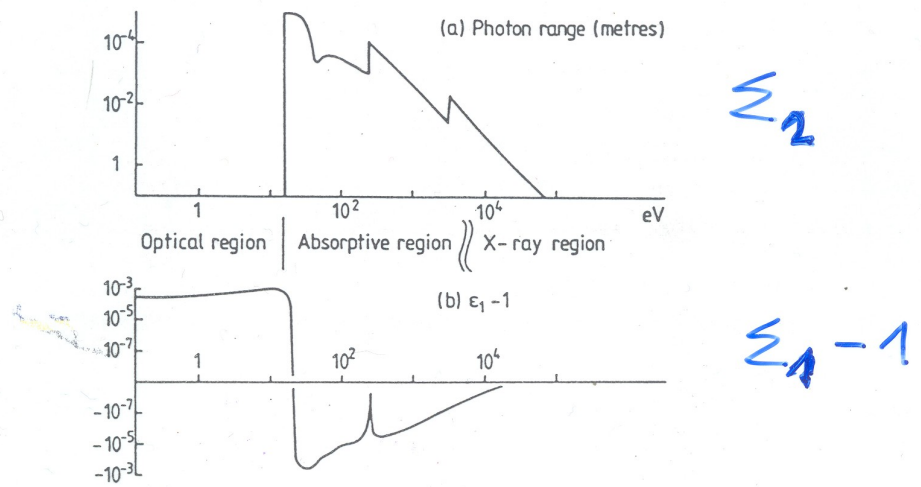


Fig.3. The dependence of ϵ for argon at normal density on photon energy,
 a) imaginary part expressed as a range and
 b) real part - 1 on a split log scale.

tri območja

a) optično $\epsilon_2 = 0$ $\epsilon_1 > 1$
 $h\omega < 2eV$

$v \geq \frac{c}{\sqrt{\epsilon}} \Rightarrow v_c \text{ realen} \rightarrow \text{sevanje Čerenkova}$

b) absorbtivno $\epsilon_2 > 0$ $\epsilon_1 < 1$
 $2eV < h\omega < 5keV$

absorbcija virtualnih fotonov \rightarrow ionizacija
 vzbujanje

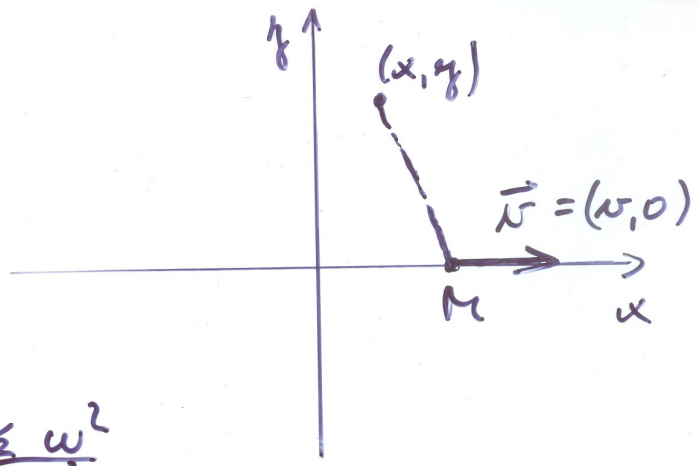
c) rentgenško $\epsilon_2 \ll 1$ $\epsilon_1 \lesssim 1$
 $h\omega > 5keV$

malo ionizacije (S-elektroni)

sevanje na prehodih snovi \rightarrow prehodno
 sevanje

iz (2)

$$n k_x = \omega$$



iz (1)

$$k^2 = k_x^2 + k_y^2 = \frac{\omega^2}{c^2}$$

$$\Rightarrow k_y = \frac{\omega}{n} \sqrt{\frac{\omega^2}{c^2} - 1}$$

vpeljimo : $c_m = \frac{c}{\sqrt{\epsilon}}$; $\beta' = \frac{\omega}{c_m}$; $\gamma' = \frac{1}{\sqrt{1-\beta'^2}}$

$$k_y = \frac{\omega}{n} \sqrt{\beta'^2 - 1} \tag{4}$$

območji: $\beta' > 1$ k_x, k_y realna
→ sevanje $e^{i(\vec{k}\vec{r} - \omega t)}$

- $\beta' < 1$ k_y imaginaren, polje
dušeno v transverzalni smeri

$$e^{i(\vec{k}\vec{r} - \omega t)} = e^{i\omega(\frac{x}{n} - t)} e^{-\frac{y}{y_0}}$$

$$y_0 = \frac{n}{\omega} \frac{1}{\sqrt{1-\beta'^2}} = \frac{\beta' \gamma'}{k} \tag{5}$$

doseg narašča $\approx \beta' \gamma'$ → relativistični dvig
 $\approx \beta \gamma$

$$y_0 = \frac{\beta}{k} \frac{1}{\sqrt{\frac{1}{\gamma^2} + (1-\epsilon) \beta^2}} \tag{6}$$

optično : $\epsilon > 1$ $\gamma' \rightarrow 1 \Rightarrow \gamma_0 \rightarrow \infty$ Čerenkov

$\epsilon < 1$ γ_0 uvažba $\approx \gamma$

$$\gamma_{0, max} = \frac{1}{k \sqrt{1-\epsilon}}$$
 (7)

nasičenje od $\frac{1}{\gamma^2} \sim (1-\epsilon) \gamma^2 \Rightarrow \gamma \gamma \sim \frac{1}{1-\epsilon}$

$1-\epsilon$ susceptibilnost $\alpha \rho$

nasičenje $\gamma \gamma \sim \frac{1}{1-\epsilon}$

večja gostota \rightarrow prej do nasičenja
 \rightarrow manjši relativistični dvig

plini $1,3 \rightarrow 1,7$ (Xe)

emulzije $1,15$

polvodniki $1,1$

plastični scint. $1,01 - 1,02$

interakcija (virtualnih) fotonov z
atomi - fotoabsorpcijski ionizacijski model

dit. preseki n.a. posameznih elektronov v
atomih v snovi

$$\frac{d\sigma}{dE} = \frac{\alpha}{\pi f^2} \frac{\sigma_F(E)}{E z} \ln \frac{1}{\sqrt{(1-f^2 \epsilon_1)^2 + f^4 \epsilon_2^2}} + (a)$$

$$+ \frac{\alpha}{\pi f^2} \frac{\sigma_F(E)}{E z} \ln \left(\frac{2mc^2 f^2}{E} \right) + (b) \quad (8)$$

$$+ \frac{\alpha}{\pi f^2} \frac{1}{E^2} \int_0^E \frac{\sigma_F(E')}{z} dE' + (c)$$

$$+ \frac{\alpha}{\pi f^2} \frac{1}{N_A c} \left(f^2 - \frac{\epsilon_1}{|\epsilon_1|^2} \right) \odot + (d)$$

$\sigma_F(E)$ - fotoabsorpcijski preseki - glej II. poglavje

\odot - faza izraza $1 - \epsilon_1 f^2 + i \epsilon_2 f^2$

(a), (b) - vzbujanje, ionizacija

(c) - Rutherfordovo sipanje \rightarrow δ -elektroni

(d) - Čerenkov + prehodno sevanje

(\odot : $0 \rightarrow \pi$)
Prag

Allison, Wright

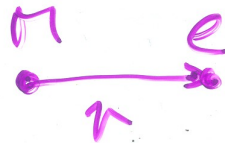
v Ferrel str. 376-382

b) energijske izgube težkih nabitih delcev ⁺

težki : vsi razen e^{\pm}

trki z elektroni - majhna sprememba energije
 - veliko tokov ($\Gamma \sim 10^{16} \text{ cm}^{-2}$)

maksimalni prenos energije



$$T_{\max} = \frac{2\gamma^2 m_e c^2 \beta^2}{1 + 2\gamma \frac{m_e}{M} + \left(\frac{m_e}{M}\right)^2} \quad (9)$$

↑
za visoke E!

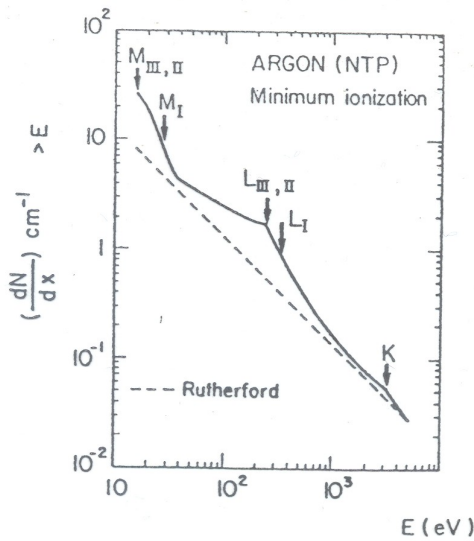


Figure 1 Collisions per unit length, in argon at NTP, with an energy transfer $\geq E$ as a function of the energy (1).

minimalni prenos energije

$T_{\min} \sim E_{\text{eksc}}$

Bethe - Blochova enačba

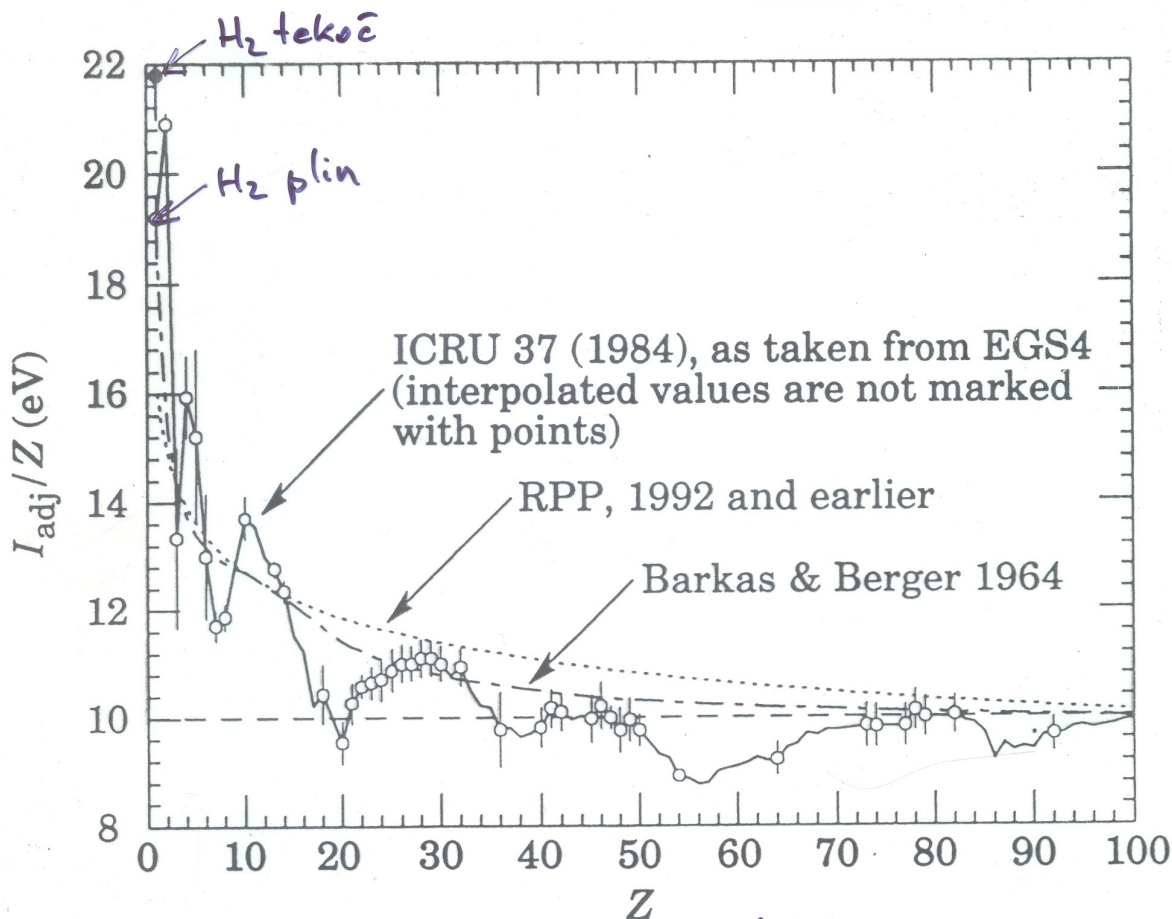
- smer M konstantna
- elektron miruje

dobimo jo tudi z integracijo enačbe (8) po prenosih energij med I in T_{max}

opiskuje povprečne izgube energije težkih delcev v snovi

I - povprečni ionizacijski potencial

$$\frac{I}{Z} \sim 10 \text{ eV} \quad (10)$$

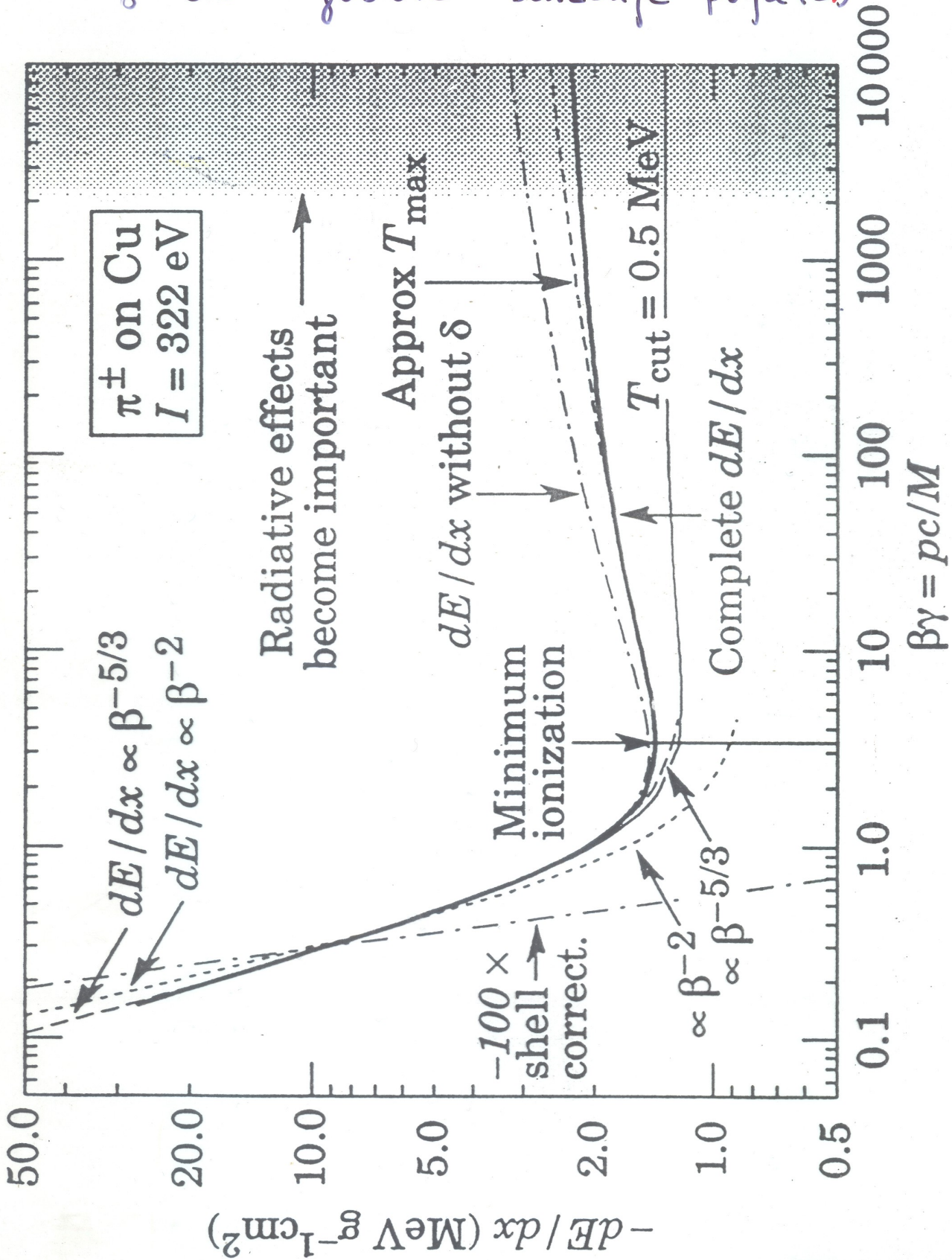


bolj natančno \rightarrow tabele

$$-\frac{dE}{dx} = k \frac{Z^2}{\beta^2} \frac{\rho \cdot Z}{A} \frac{1}{\beta^2} \left[\frac{1}{2} \ln \frac{2 m_e c^2 \beta^2 \gamma^2 T_{\max}}{I} - \beta^2 - \frac{\delta}{2} \right] \quad (1)$$

$$k = 4\pi N_A r_e^2 m_e c^2 = 0.307 \text{ MeV} \frac{\text{cm}^2}{\text{g}}$$

δ - efekt gostote - senčenje polja (ϵ !)



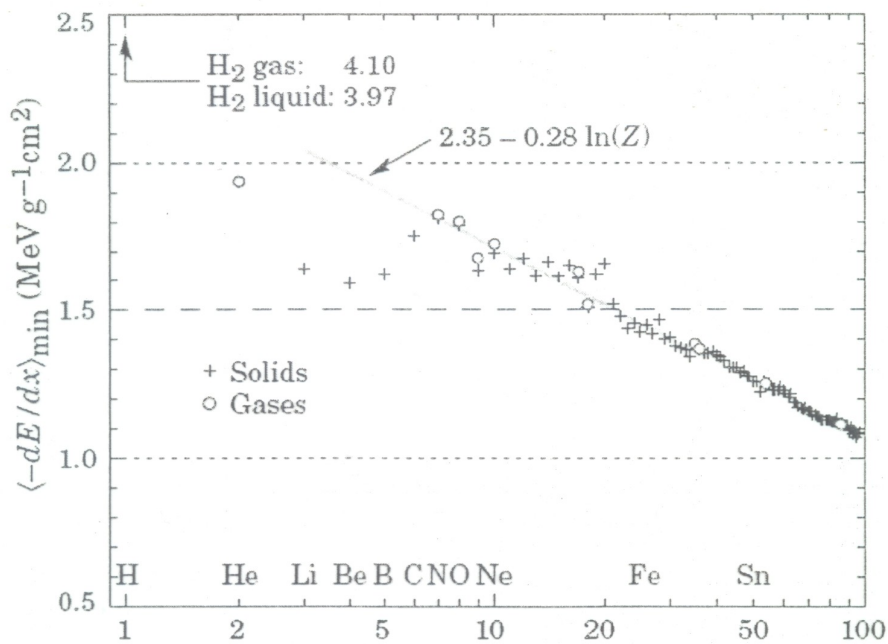
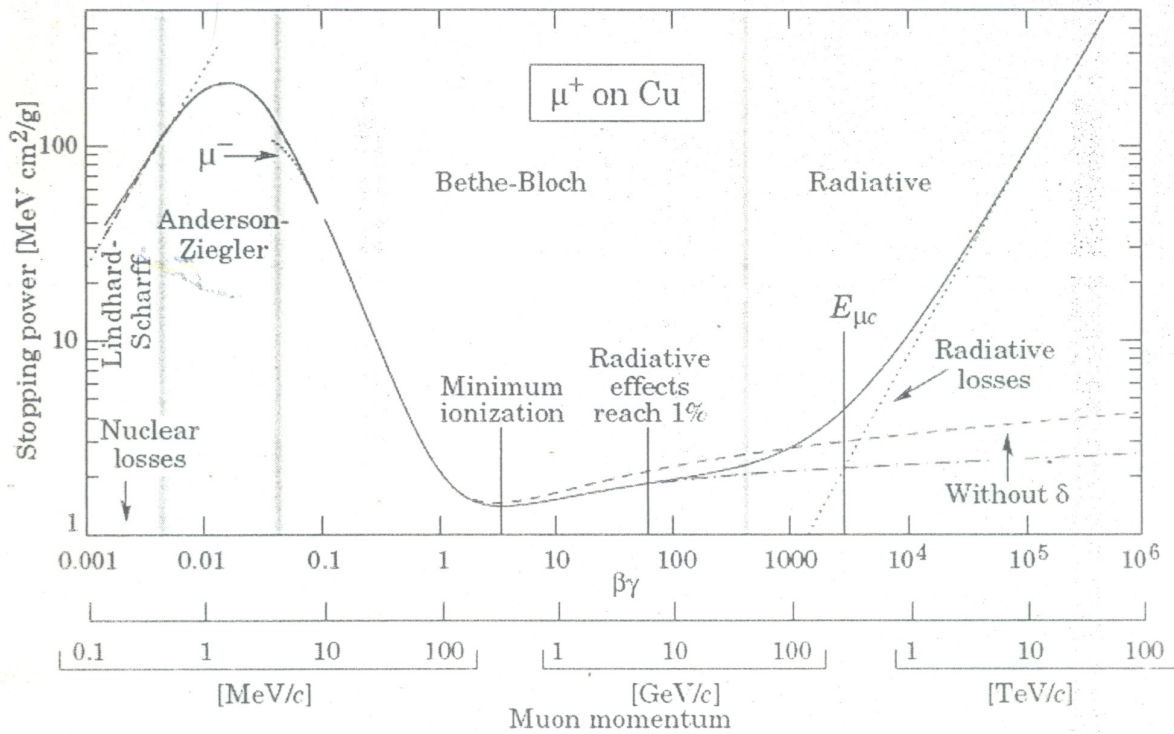


Figure 27.2: Stopping power at minimum ionization for the chemical elements. The straight line is fitted for $Z > 6$. A simple functional dependence on Z is not to be expected, since $\langle -dE/dx \rangle$ also depends on other variables.

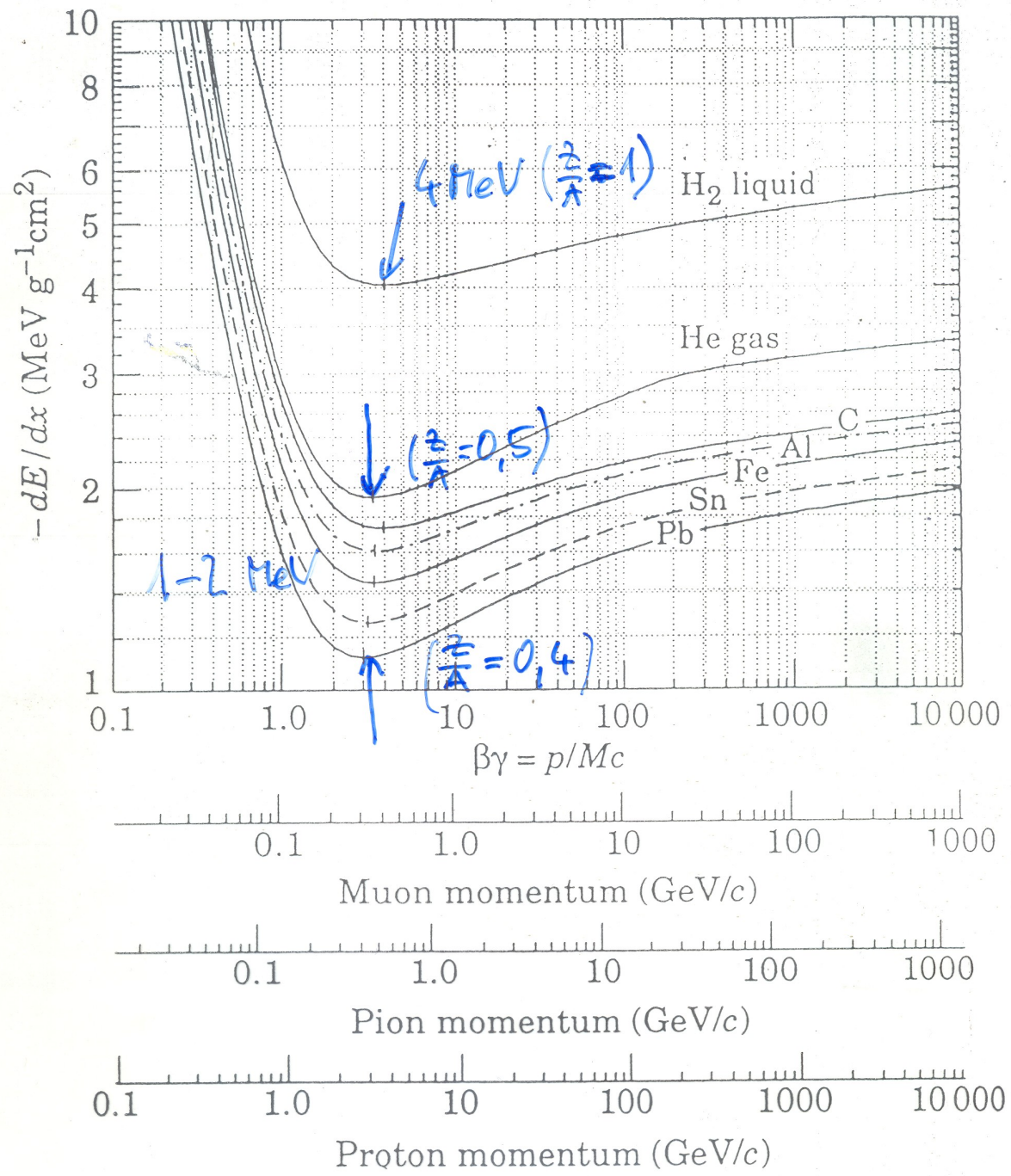


Figure 22.2: Energy loss rate in liquid (bubble chamber) hydrogen, gaseous helium, carbon, aluminum, tin, and lead.

za dan medij $\rightarrow \frac{dE}{dx} = f(w) = g\left(\frac{Z}{A}\right) = h\left(\frac{T}{T_{max}}\right)$ ¹⁰

energijska odvisnost

majhni $\gamma > \frac{Z}{137} \rightarrow \frac{dE}{dx} \propto \frac{1}{\gamma^2} (\gamma^{-5/3})$

$\gamma \sim 3,5$ širok
 $\gamma \sim 0,96$ minimum 1-2 MeV $\frac{cm^2}{g}$

visoki: $\gamma \gg 4$ relativistični
 dvig

rel. dvig - počasen $\sim 2 \ln \gamma \xrightarrow{\gamma \gg 1} \ln \gamma$
 - zmanjšan zaradi gostote
 $\gamma \gg 1: \delta/2 = \ln(kw_p/I) + \ln \gamma - 1/2$
 - visokoenergijski elektroni uidejo
 \rightarrow Fermijev plato

omejene energijske izgube: $T < T_{rez}$

$$\frac{-dE}{dx} \Big|_{T < T_{rez}} = K \frac{Z^2}{A} \frac{1}{\gamma^2} \left[\frac{1}{2} \ln \frac{2mc^2 \gamma^2 T_u}{I} - \frac{T_u}{T_{max}} \right] \quad (12)$$

$T_u = \min(T_{rez}, T_{max})$ \sim deponirana energija

delež visokoenergijskih elektronov (δ -el.)¹¹

$$\frac{d^2 N}{dT dx} = \frac{1}{2} K z_p^2 \frac{\rho z}{A} \frac{1}{\beta^2} \frac{F(T)}{T^2} \quad (13)$$

$$I \ll T < T_{\max}$$

$F(T)$ odvisen od spina; $F \sim 1$ za $T \ll T_{\max}$

$$\Rightarrow \frac{dN}{dx} |_{E > E_0} \sim C/E_0 \quad (14)$$

za Ar, 1 GeV μ

$$1 \text{ e/m} \text{ z } E > 10 \text{ keV}$$

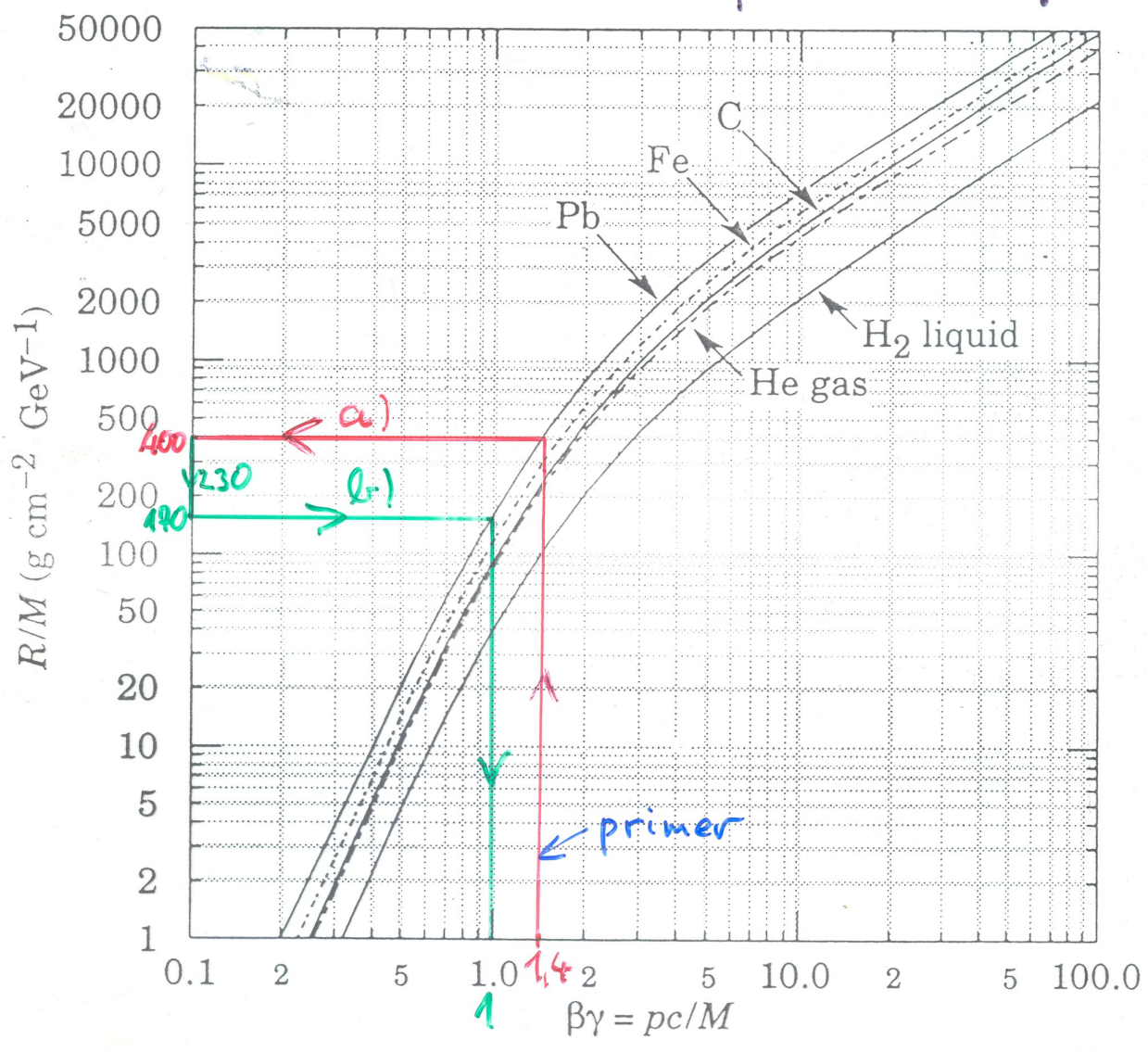
ustavljanje delca



doseg

$$R(E) = \int_E^0 \frac{dE}{\left(\frac{dE}{dx}\right)} \quad (15)$$

v resnici je to pot delea, toda sipanje le malo pokvari relacijo pot = doseg



zveza

(16)

$$R_a(M_a, z_a, \left\{ \frac{p_a}{T_a} \right\}) = \frac{M_a z_b^2}{M_b z_a^2} R_b(M_b, z_b, \left\{ \frac{p_b}{T_b} \right\}) = \left\{ \frac{p_a}{T_a} \right\} \frac{M_b}{M_a}$$

primer: $m = 494 \text{ neV}$
 $K^+, p = 400 \text{ neV/c, Pb} : p \Rightarrow \beta\gamma = 1.42 ; \text{Pb} : R/M = 400$
 $c = 11.35 \text{ g/cm}^3$

a) $\Rightarrow R = 135 \text{ g/cm}^2 \Rightarrow R = 17.4 \text{ cm}$
 b) $d = 10 \text{ cm} \Rightarrow \frac{R}{M} = 230 \Rightarrow R/M = 170 \Rightarrow \beta\gamma = 1 \Rightarrow p = 500 \text{ neV/c}$

Doseq

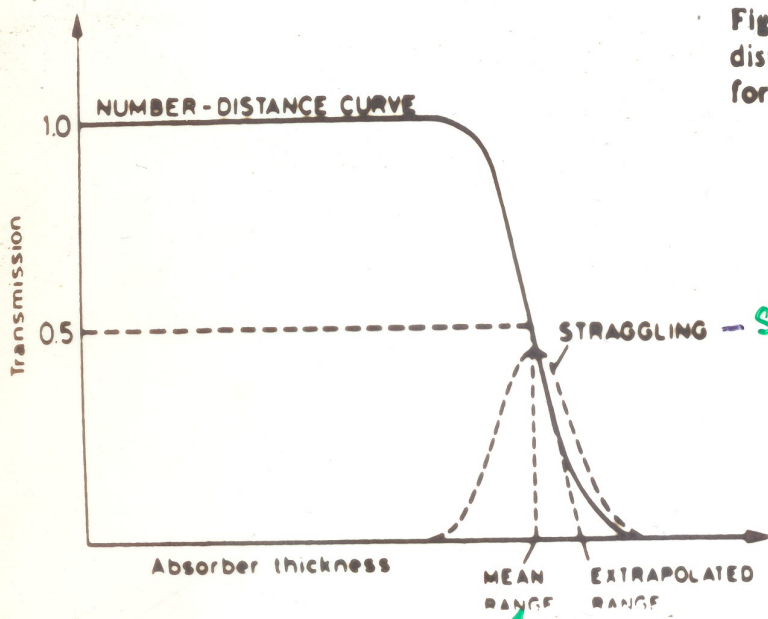


Fig. 2.7. Typical range number-distance curve. The distribution of ranges is approximately Gaussian in form

stresanje

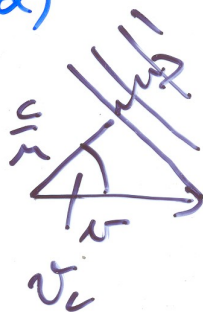
↑
povprečni
doseq

sevanje Čerenkova

optično področje $v > \frac{c}{n}$

opis z enačbo (8 d)

$$\cos \theta_c = \frac{1}{\beta n}$$



(17)

$$\beta n \gg 1 \rightarrow \theta_c \rightarrow 0$$

$$\beta \sim 1 \quad \cos \theta_c = \frac{1}{n}$$

 H_2O

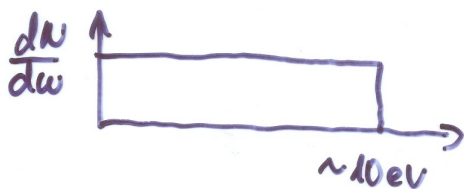
$$\theta_c = 41^\circ$$

 SiO_2

$$\theta_c = 47^\circ$$

↳ totalni odboj $\sin \alpha_m = \frac{1}{n}$

$$iz (8): \frac{dN}{dE_\gamma} = \frac{L}{hc} \left(1 - \frac{1}{\beta^2 n^2}\right) L \propto \sin^2 \theta_c \cdot L \quad (18)$$

za optično področje $n(\omega) \sim \text{konst.}$ 

$$\frac{dE}{dx} = \frac{1}{L} \int h\omega \frac{dN}{dE_\gamma} dE_\gamma \quad (19)$$

majhen, za trdno snov $\sim 10^{-3} \text{ Mev} \frac{\text{cm}^2}{g}$ ali $\sim 10^3$ fotonov (večina UV)

c) Energijske izgube e^{\pm}

trki z elektroni ν kot teži delci

- toča**
- velik odklon it smeri
 - identični delci (e)
 - $W_{\max} = \frac{T_e}{2}$

v Bethe - Bloch

$$\ln \frac{2 m e c^2 \beta^2 \gamma^2 T_{\max}}{I^2} \rightarrow \ln \frac{\beta^2 (\beta+2)}{2 (I/m e c^2)^2}$$

$$\beta = \frac{T}{m e c^2}$$

$$-\beta^2 \rightarrow F(\beta) \quad (\text{Leo str. 35})$$

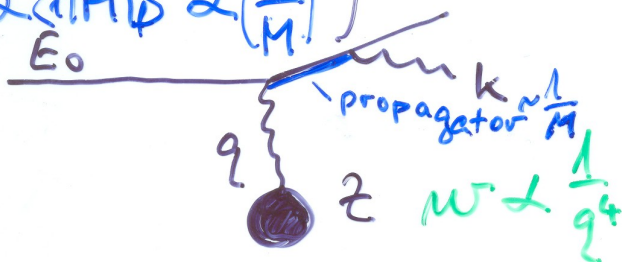
lahki delci

zavorno

sevanje

poma- $(W \propto \beta^2 \alpha^2 \propto \left(\frac{z}{M}\right)^2)$ za $\mu \sim 60000$ manjša

gali $(W \propto \frac{1}{M^2} \propto \left(\frac{1}{M}\right)^2)$



sevanje jedra z atomskimi elektroni

najugodnejši q pada z energijo

\rightarrow dlje stran \rightarrow večje sevanje

15

za $E_0 > 137 m_e c^2 z^{1/3}$ popolno senčenje

$$\underline{E = E_0 e^{-\frac{x}{X_0}}} \quad (20)$$

X_0 - radiacijska dolžina

$$\underline{\frac{1}{X_0} \approx \frac{4z^2 \rho N_A}{A} r_e^2 \ln(183 z^{-1/3})} \quad (21)$$

$$\underline{\frac{1}{X_0} \approx \frac{\rho z^2}{A}} \quad (22)$$

primeri

	ρX_0	X_0
C	42,7 g/cm ²	18,8 cm
Pb	6,37 g/cm ²	0,56 cm
W	6,76 g/cm ²	0,35 cm

efekt zavornega sevanja na elektronih

$$z^2 \rightarrow z(z+1)$$

RPP '96:

$$\underline{\rho X_0 = \frac{716,4 \text{ g/cm}^2 \text{ A}}{z(z+1) \ln(287/\sqrt{z})}} \quad (23)$$

napaka $\pm 2,5\%$

kritična energija

$$\left(\frac{dE}{dx}\right)_{trki} = \left(\frac{dE}{dx}\right)_{rad}$$

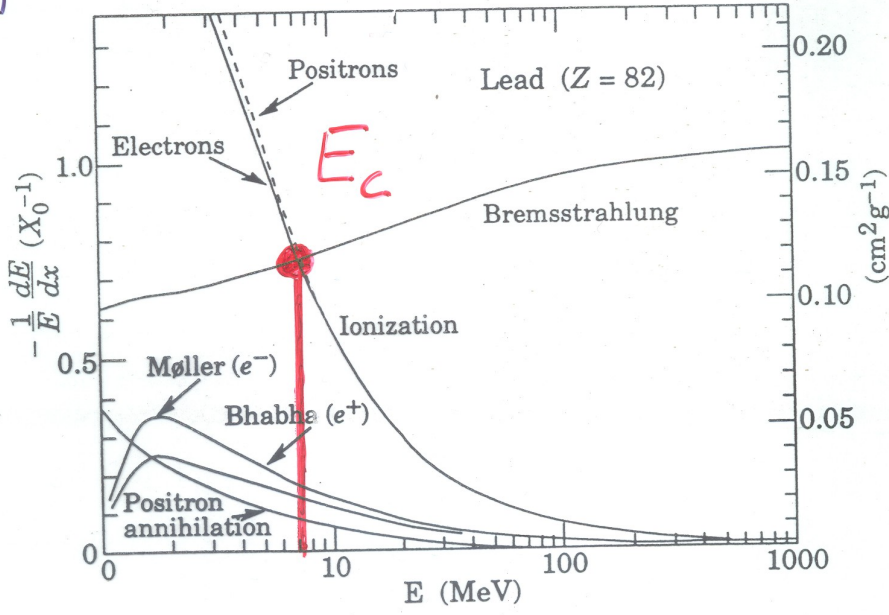
$$E_c \sim \frac{800 \text{ MeV}}{Z + 1,2} \quad (24)$$

Pb ~ 9,5 MeV Al ~ 51 MeV

RPP 196 plini ↔ tekočine + trdne (I!)

drugačnja definicija plin 710 MeV / (Z + 0,92)

(→ 16b) T+T. 610 MeV / (Z + 1,24) Pb ~ 9,5 MeV



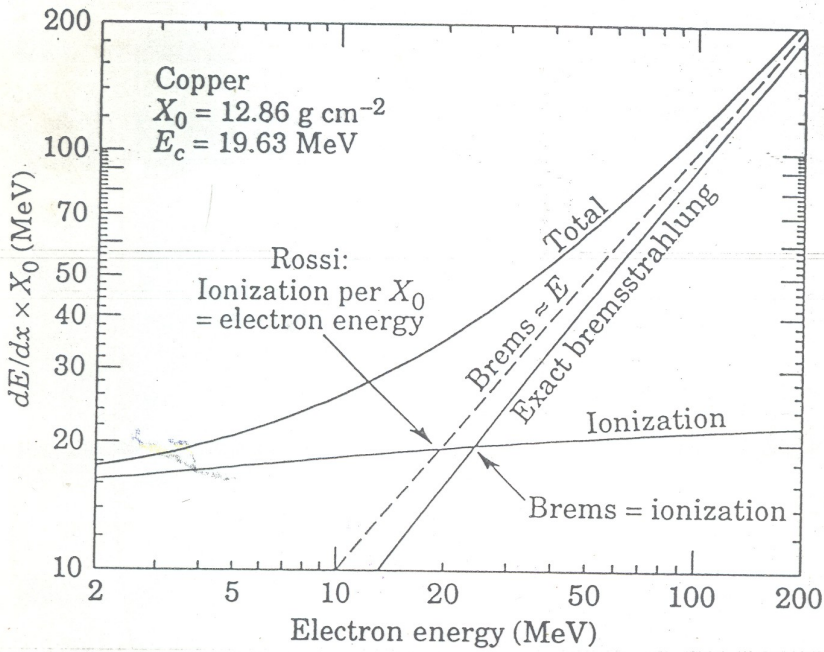


Figure 22.6: Two definitions of the critical energy E_c .

"nova" (Rossi 1952!) definicija E_c

$$\left(\frac{dE}{dx}\right)_{ion} \cdot X_0 = E (\equiv E_c)$$

definiciji identični za $\left(\frac{dE}{dx}\right)_{zavorno} = \frac{E}{X_0}$

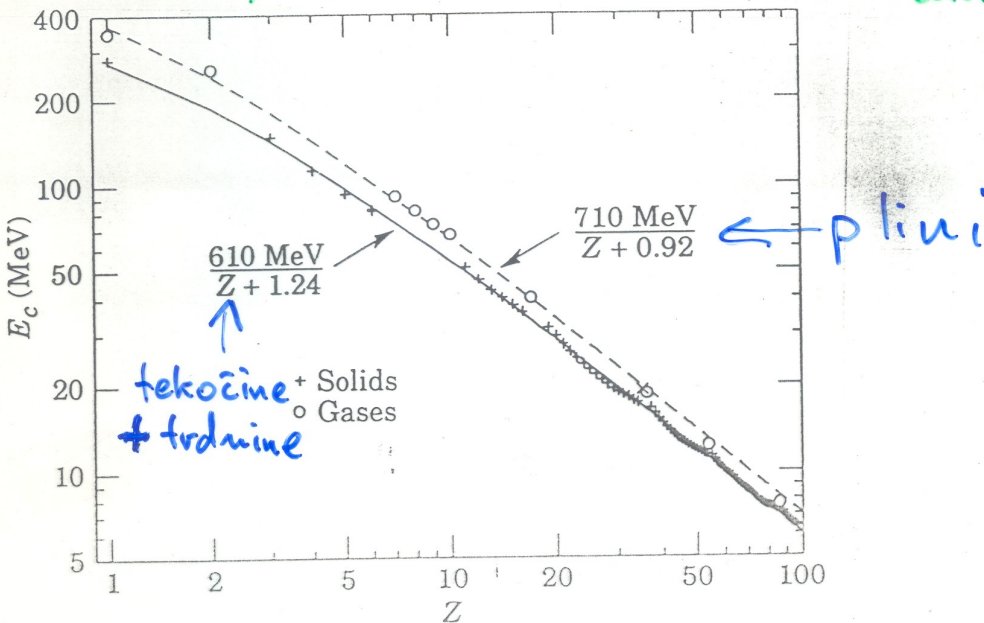


Figure 22.7: Electron critical energy for the chemical elements, using Rossi's definition [1]. The fits shown are for solids and liquids (solid line) and gases (dashed line). The rms deviation is 2.2% for the solids and 4.0% for the gases. (Computed with code supplied by A. Fassó.)

LPM – Landau-Pomeranchuk-Migdal

Pri visokih energijah potekajo majhni prenos energij preko več atomov, pomembno če

$$E_\gamma < E^2 / (E + E_{LPM})$$

kjer je

$$E_{LPM} = \frac{(m_e c^2)^2 \alpha X_0}{4\pi h c \rho} = (7.7 \text{ TeV/cm}) \times \frac{X_0}{\rho}$$

Formacijska dolžina – interferenca med sevalci (atomi) na tej dolžini (destruktivna)

Senčenje v snovi !

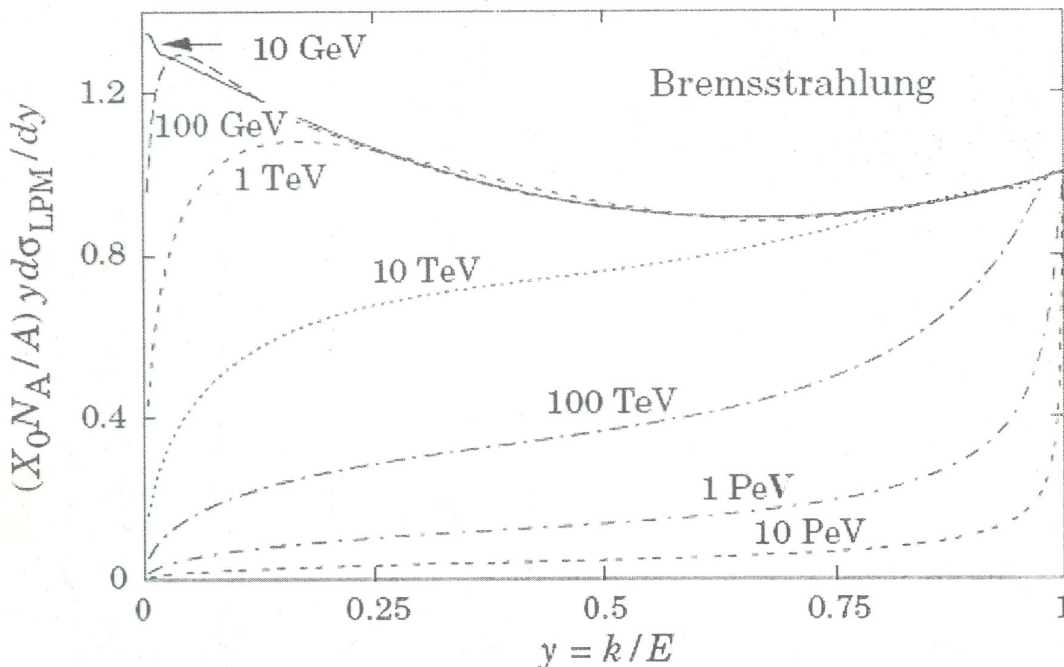


Figure 27.11: The normalized bremsstrahlung cross section $k d\sigma_{LPM}/dk$ in lead versus the fractional photon energy $y = k/E$. The vertical axis has units of photons per radiation length.

Doseg elektronov

- veliko stresanje zaradi sipanja

- za β -razpad efektivno $I = I_0 e^{-\mu x}$

spekter & doseg
le dovoljenij prehodi

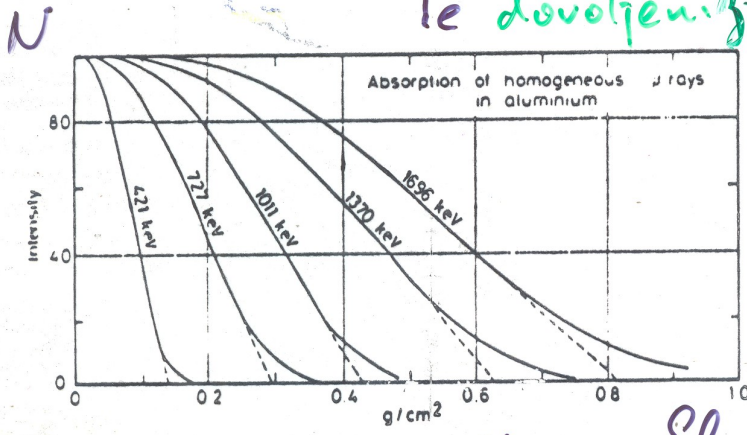


Fig. 2.11. Range number-distance curves for electrons (from Marshall and Wurd (2.15))

Fig. 2.12. Range curves for electrons in several materials as calculated in the continuous slowing down approximation (data from (2.16))

Fig. 2.13. Absorption curves for beta decay electrons from ¹⁸⁵W (from Baltakamens et al. (2.17))

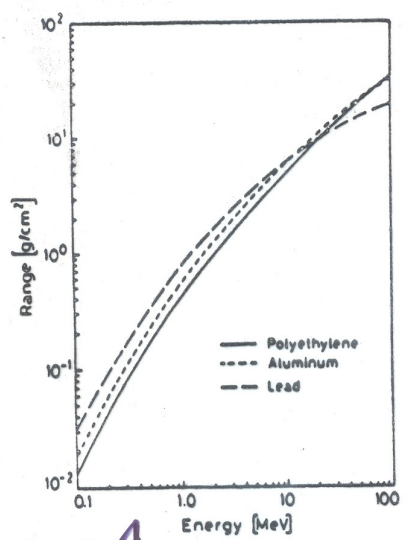


Fig. 2.12

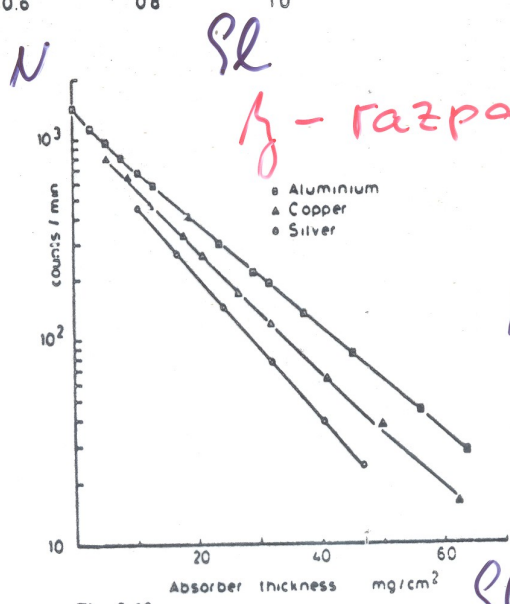


Fig. 2.13

β -razpad

$$N = N_0 e^{-\frac{\mu}{\rho} x}$$

$$R = \int_{E_0}^0 \frac{dE}{dE/dx}$$

d) Večkratno Coulombsko sipanje
 sipanje na jedrih $M_j \gg M$

Rutherford: $\frac{d\sigma}{d\Omega} = Z_1^2 Z_2^2 r_e^2 \frac{m_e c^2}{4\epsilon_0^2 \sin^4 \frac{\theta}{2}}$

\Rightarrow majhni koti

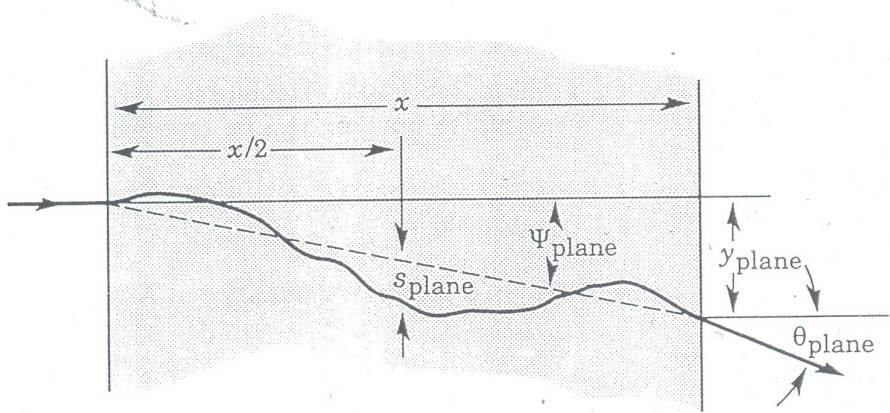
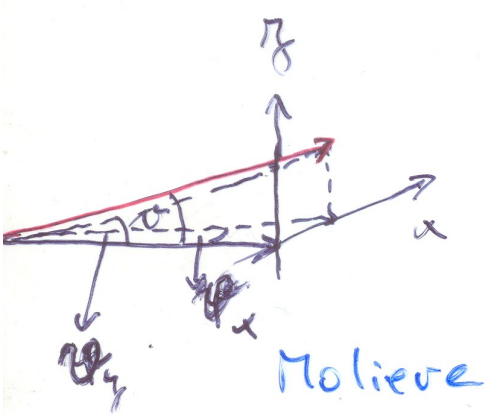


Figure 10.5: Quantities used to describe multiple Coulomb scattering. The particle is incident in the plane of the figure.

trije režimi:

- tanek absorber $N_s < 1$; Rutherford
- vmesno področje $1 < N_s < 20$ ni statistično
- večkratno sipanje $N_s > 20$ statistično



$P(\theta) d\theta = \eta d\eta \left(2e^{-\eta^2} + \frac{F_1(\eta)}{B} + \frac{F_2(\eta)}{B^2} + \dots \right)$

$\eta = \frac{\theta}{\theta_1 \sqrt{B}}$ $\theta_1 = 0.4 \left(\frac{zQ}{p \beta} \right) \sqrt{\frac{9L}{A}}$

$$B: \quad \ln B - B + \ln \gamma - 0.154 = 0$$

$$\gamma = 8.831 \cdot 10^3 \frac{q z^2 Q L}{h^2 A \Delta}; \quad \Delta = 1.13 + 3.76 \left(\frac{z z}{134 q} \right)^2$$

$$F_k(\eta) = \frac{1}{k!} \int_0^\eta f_0(\eta y) e^{-\frac{\eta^2}{4}} \left[\frac{\eta^2}{4} \ln \frac{\eta^2}{4} \right]^k \eta dy$$

$$Q = \begin{cases} \sqrt{z(z+1)} & e^{\frac{1}{2}} \\ z & \text{ortalo} \end{cases}$$

$$q = \begin{cases} (z+1) z^{1/3} & e^{\frac{1}{2}} \\ z^{4/3} & \text{ortalo} \end{cases}$$

GEANT računa VCS do F_2 !

oblika \rightarrow Gaussova sredica (98%)
+ repi

Gaussova sredica

$$P(v) dv = \frac{2v}{v_0^2} e^{-\frac{v^2}{v_0^2}} dv \quad (26)$$

$$v_0 = \sqrt{\langle v^2 \rangle} \quad v_0 \sim v_1 \sqrt{B}$$

empirično

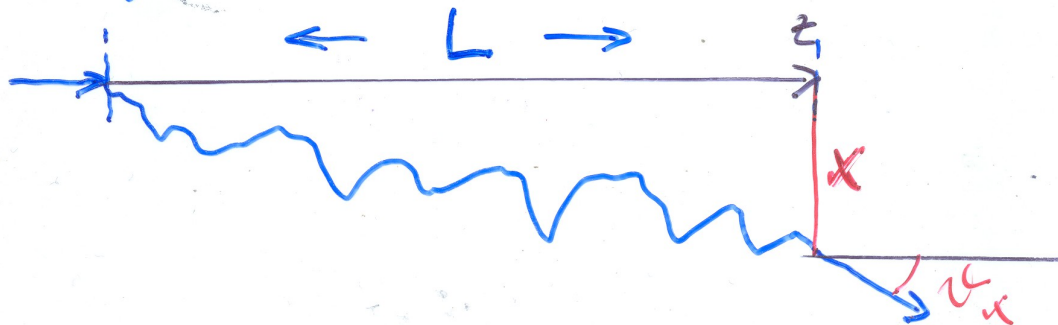
$$v_0 = Z_p \frac{20 \text{ MeV}}{\mu \text{ g.c.}} \sqrt{\frac{L}{X_0}} \left(1 + \frac{1}{3} \log_{10} \frac{K}{X_0} \right) \quad (27)$$

projekciji na ravnino: v_x, v_y

20

$$P(v_x) dv_x = \frac{1}{\sqrt{2\pi}\sigma_0'} e^{-\frac{v_x^2}{2\sigma_0'^2}} \quad (28)$$

enako za v_y ; majhni koti $\rightarrow v^2 = v_x^2 + v_y^2$
 v_x, v_y neodvisna $\Rightarrow \sigma_0^2 = 2\sigma_0'^2$ (RPP: $\sigma_0 \rightarrow \sigma_0'$)

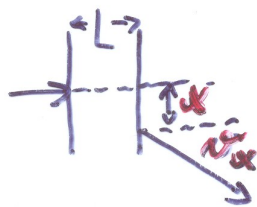


$$P(x) dx = \frac{1}{\sqrt{2\pi}\sigma_0} e^{-\frac{x^2}{2\sigma_0^2}} dx \quad (29)$$

$$\sigma_0 = \frac{L\sigma_0'}{\sqrt{3}}$$

x in v_x korelinana ($\rho = \frac{\sqrt{3}}{2}$)

MC recept



$$z_1, z_2 \in N(0,1)$$

$$x = z_1 L \sigma_0' / \sqrt{12} + z_2 L \sigma_0' / 2$$

$$v_x = z_2 \sigma_0'$$

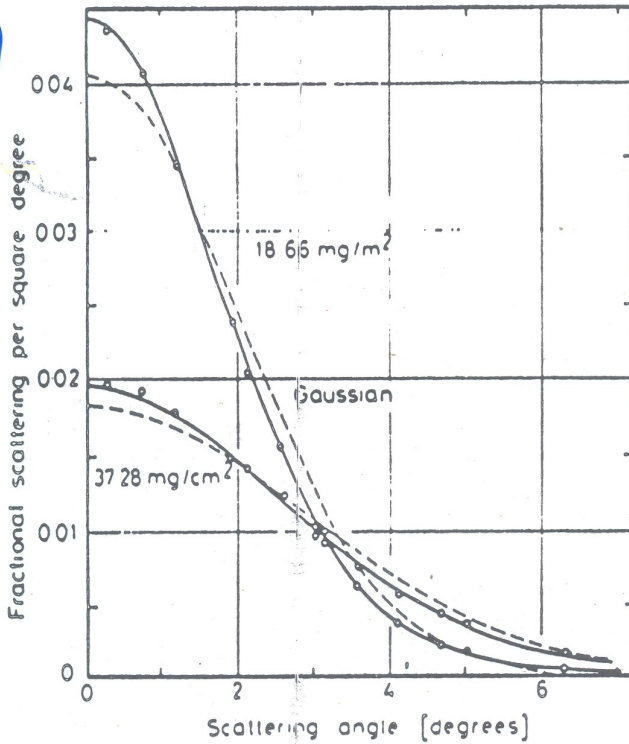
enako za y, v_y

povratno sipanje

nekaj elektronov nazaj - $f(\nu, E, z)$

44

$P(\theta)$



VCS
na zlatu

albedo - verjetnost za sipanje nazaj

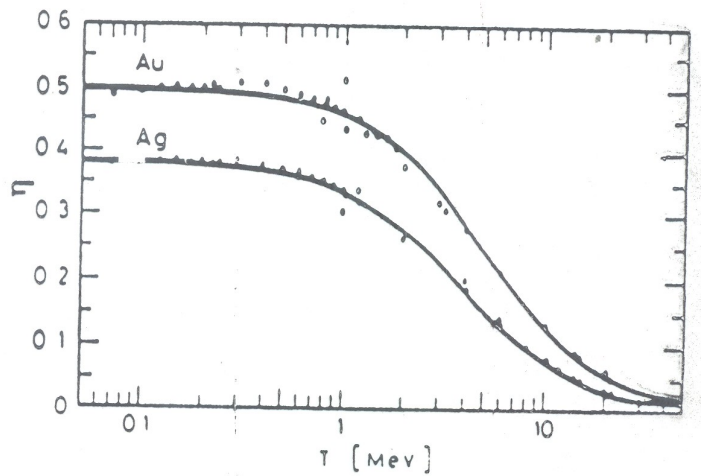
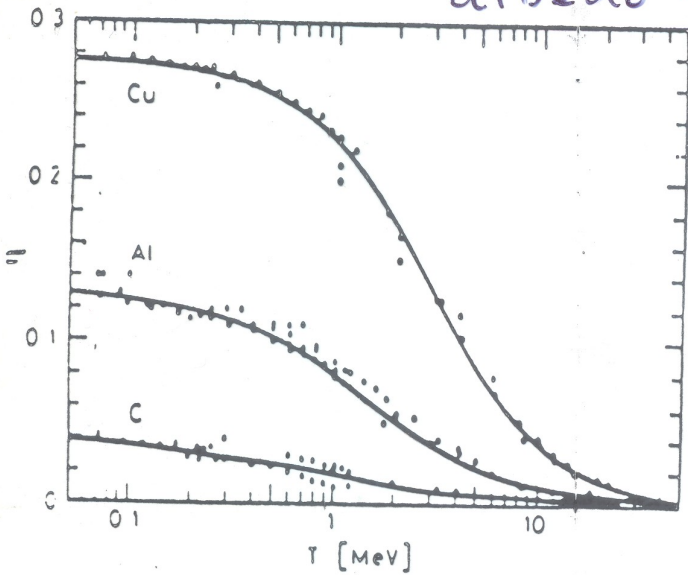


Fig. 2.17. Some measured electron backscattering coefficients for various materials. The electrons are perpendicularly incident on the surface of the sample (from Tabata et al. [2.24])

c) Energijsko stresanje

Bethe Bloch poda le srednjo vrednost dE/dx
 stresanje dosega \leftrightarrow stresanje en. izgub

debeli absorberji \rightarrow izrek o srednji vrednosti \rightarrow Gauss
 tanki absorberji \rightarrow malo trkov

parameter $\mathcal{R} = \frac{\bar{\Delta}}{T_{\max}}$ $\bar{\Delta}$ - Bethe Bloch
 $T_{\max} \approx 2 m_e c^2 \gamma^2 \beta^2$

$\mathcal{R} > 10$ ($\gamma > 1$) in $\frac{\Delta}{E_0} \ll 1$ debeli absorberji

$$P(\Delta) = \frac{1}{\sqrt{2\pi}\sigma_0} \exp\left[-\frac{(\Delta - \bar{\Delta})^2}{2\sigma_0^2}\right] \quad (30)$$

$$\sigma_0^2 = \frac{1 - \frac{1}{2}\beta^2}{1 - \beta^2} \cdot \underbrace{0.1569}_{4\pi N_A r_e^2 (m_e c^2)^2} \cdot \frac{Z}{A} \cdot L \quad [\text{MeV}^2] \quad (31)$$

zelo debeli absorberji $\frac{\Delta}{E_0} \rightarrow 1$

Gauss ne velja \rightarrow numerična integracija

tanki absorberji $T_{\max} > \bar{\Delta}$
 rep proti visokim dE/dx (S-elektroni!)

$$\bar{\Delta} \neq \Delta_{\text{mp}}$$

zelo tanki absorberji $\chi < 0.01$

23

- Landau:
- $T_{max} \rightarrow \infty$ ($\chi \rightarrow 0$)
 - prosti elektroni ($\delta_1 > E_{at}$)
 - ν konstantna
 - $\bar{\Delta}$ brez ln člena

$$\bar{\Delta} \rightarrow \xi = 2\pi N_A n_e^2 m_e c^2 \rho \frac{z}{A} \left(\frac{z_p}{\rho}\right)^2 d$$

$$P(\Delta) = \phi(\chi) / \xi$$

$$\phi(\chi) = \frac{1}{\pi} \int_0^{\infty} e^{-u \ln u - u \chi} \sin \pi u \, du$$

$$\chi = \frac{1}{\xi} [\Delta - \xi (\ln \xi - \ln \Sigma + 1 - C)]$$

C - Eulerjeva konstanta = 0.577

$$\ln \Sigma = \ln \frac{(1-\beta^2) I^2}{2mc^2 \beta^2} + \beta^2 \quad \text{minimalni transfer (eto prosti)}$$

$\phi(\chi)$ - tabelirana, neodvisna od d.

$$\underline{\Delta_{mp} = \xi [\ln(\xi/\Sigma) + 0.138 - \delta]} \quad (33)$$

srednje debeli absorberji $0.01 < \chi < 10$ (1)

pora zdelitev Vavilova \rightarrow Landau + T_{max}

limiti $\chi \rightarrow 0$ Landau

$\chi \rightarrow \infty$ Gauss

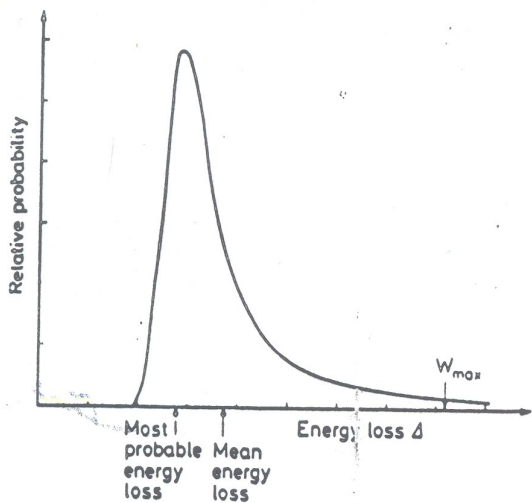


Fig. 2.18. Typical distribution of energy loss in a thin absorber. Note that it is asymmetric with a long high energy tail

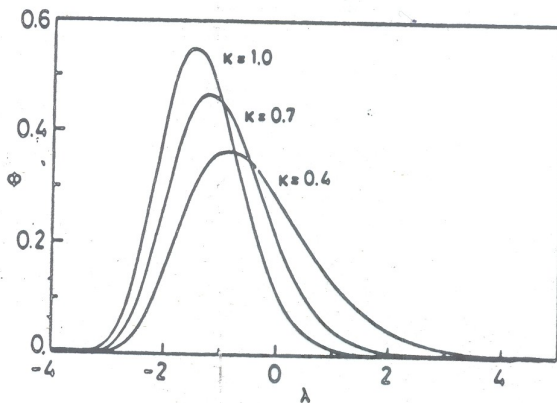
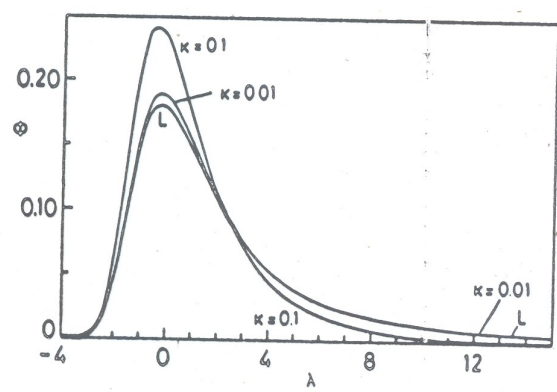
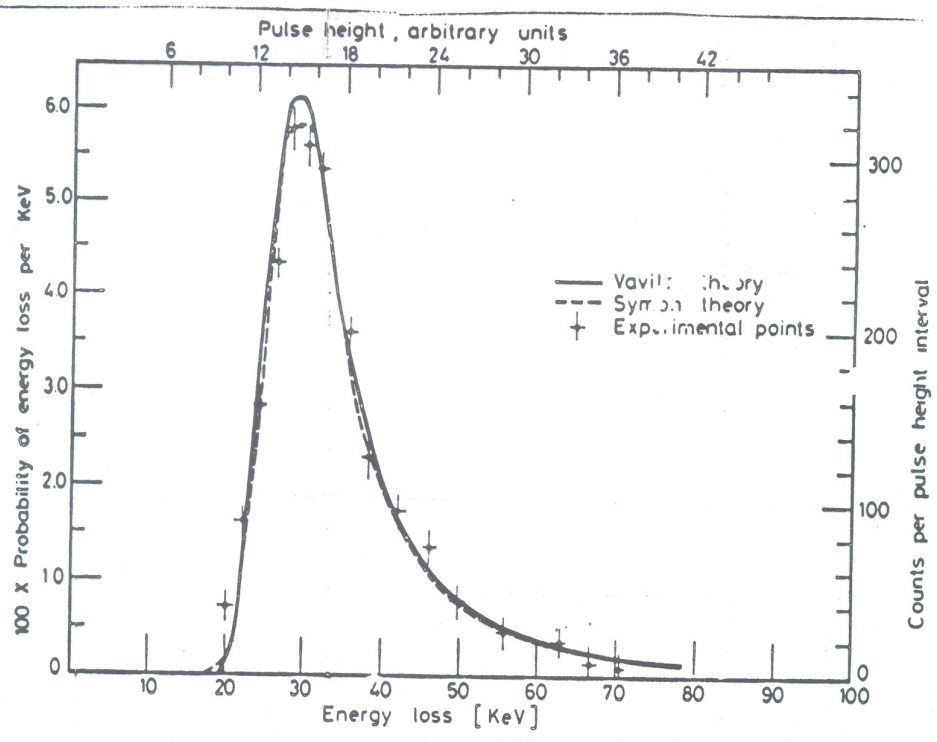


Fig. 2.19. Vavilov distributions for various κ . For comparison, Landau's distribution (denoted by the L) for $\kappa = 0$ is also shown (from Seltzer and Berger [2.29])



f) energijske izgube visokoenergijskih mioinov 24a

$$-\frac{dE}{dx} = a(E) + b(E)E \quad (33a)$$

$a(E)$ - ionizacija $\sim 2 \text{ MeV/gcm}^2 \sim \text{konst}$
 $b(E)$ - zaverno sevanje
 - tvorba parov
 - fotojedrske reakcije } $\sim \text{konst. za } E_\mu > \text{TeV}$

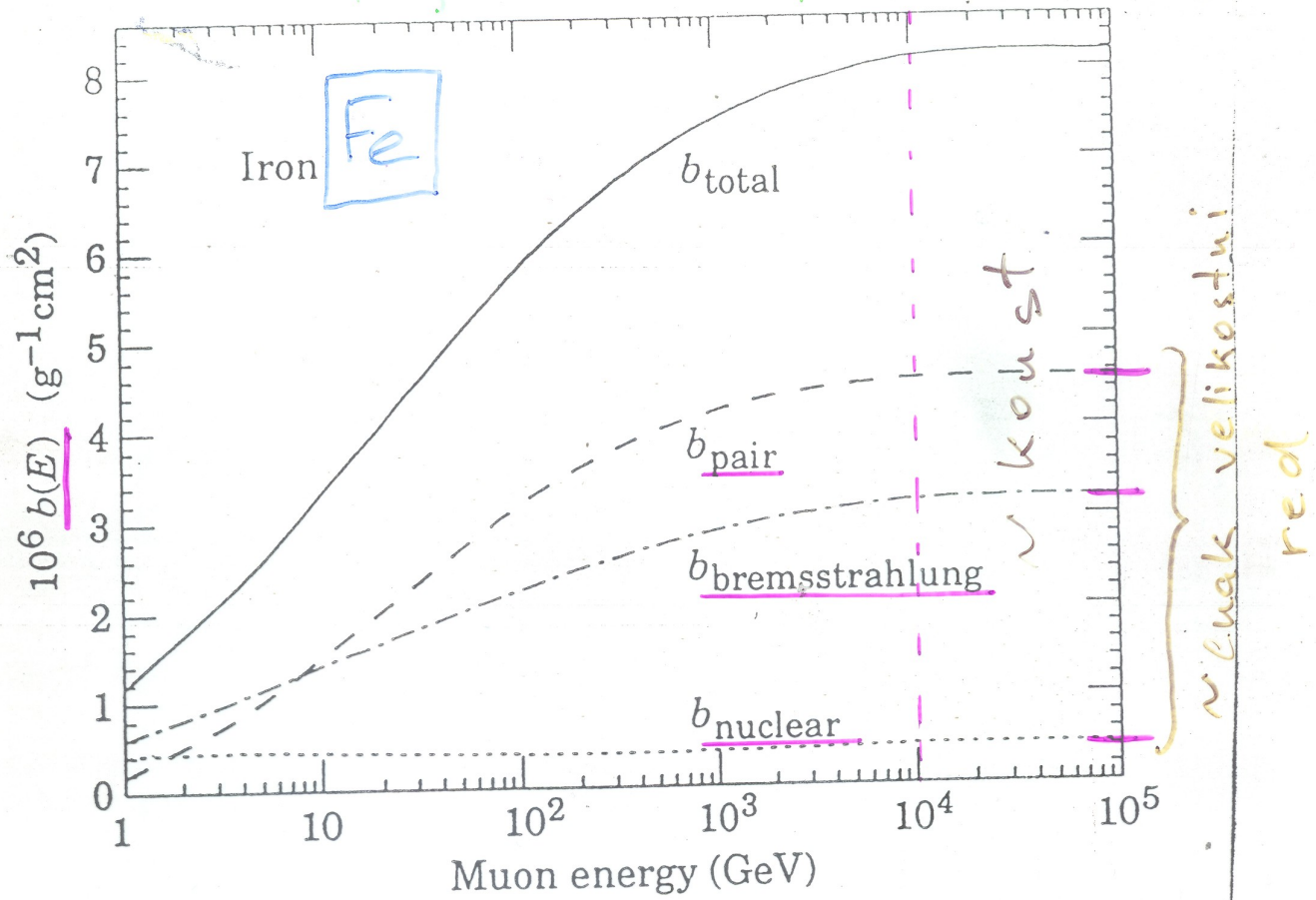
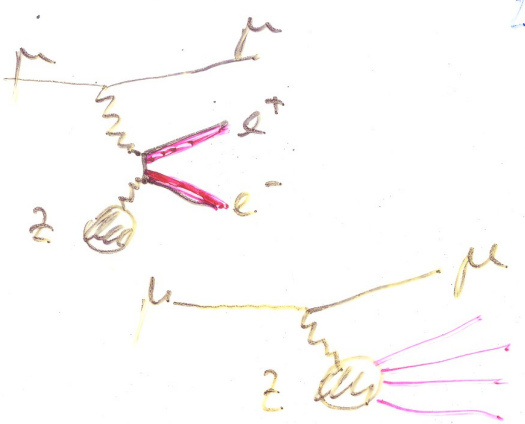


Figure 22.10: Contributions to the fractional energy loss by muons in iron due to e^+e^- pair production, bremsstrahlung, and photonuclear interactions, as obtained from Lohmann *et al.* [39].

zaverno sevanje - kot za elektrone $\epsilon E_e = E_\mu \left(\frac{m_e}{m_\mu}\right)^2$
 25 MeV $\sim 10^4 \text{ GeV}$

tvorba parov
 (enako za e, μ)
 (zav. sevanje $\times 40000$)



hadronski fragmenti

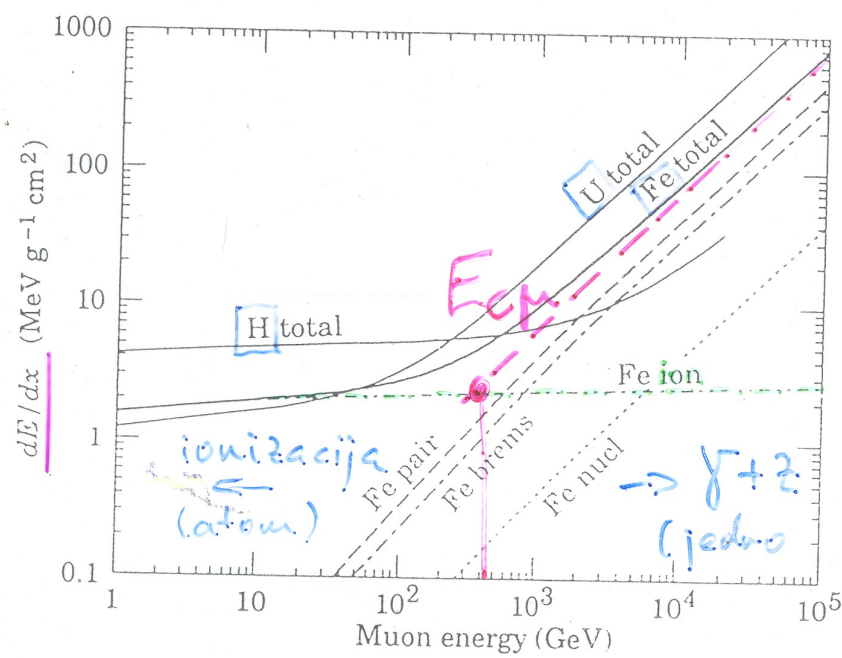


Figure 22.11: The average energy loss of a muon in hydrogen, iron, and uranium as a function of muon energy. Contributions to dE/dx in iron from ionization and the processes shown in Fig. 22.10 are also shown.

kritična energija

$$E_{\mu c}$$

$$E_{\mu c} = \frac{a(E_{\mu c})}{b(E_{\mu c})} \sim \frac{a}{b}$$

$a, b \sim \text{konst}$

doseg

$$x_0 \sim \frac{1}{b} \ln\left(1 + \frac{E_0}{E_{\mu c}}\right)$$

$$E_0 \ll E_c: x_0 = \frac{E_0}{a}$$

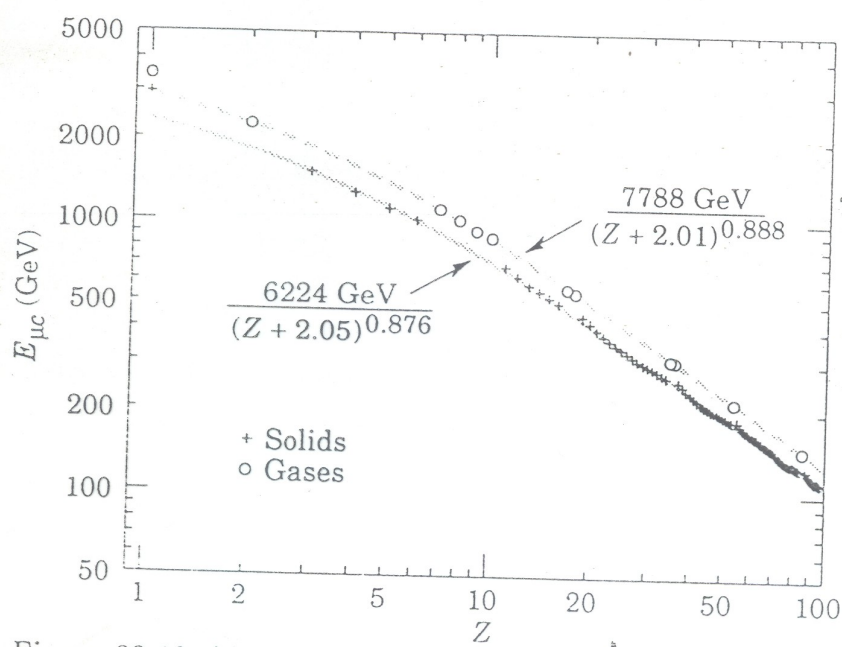


Figure 22.12: Muon critical energy for the chemical elements, defined as the energy at which radiative and ionization energy loss rates are equal. The equality comes at a higher energy for gases than for solids or liquids with the same atomic number because of a smaller density effect reduction of the ionization losses. The fits shown in the figure exclude hydrogen. Alkali metals fall 3-4% above the fitted function for alkali metals, while most other solids are within 2% of the function. Among the gases the worst fit is for neon (1.4% high). (Courtesy of N.V. Mokhov, using the MARS code system [48].)

le povprečne energijske izgube

zavorno sevanje

$$E_{\gamma} \frac{d\Gamma}{dE_{\gamma}} \sim \text{konst} \Rightarrow \left(\frac{dN}{dE_{\gamma}}\right)_{\gamma} \propto \frac{1}{E_{\gamma}}$$



ne more velike energije

stresanje dE_{μ}/dx

24c

(1) $\frac{dE_{\text{ioni}}}{dx} > \frac{dE_{\text{r}}}{dx} > \frac{dE_{\text{fotojed.}}}{dx}$

- (2) spekter produktov - zelo trd fotojedrske
 - trd zavorno sevanje
 - mehkejši tvorba parov

⇒ velike $\frac{dE}{dx}$ posledice redkih
 - trdih fotonov
 - fotojedrskih reakcij

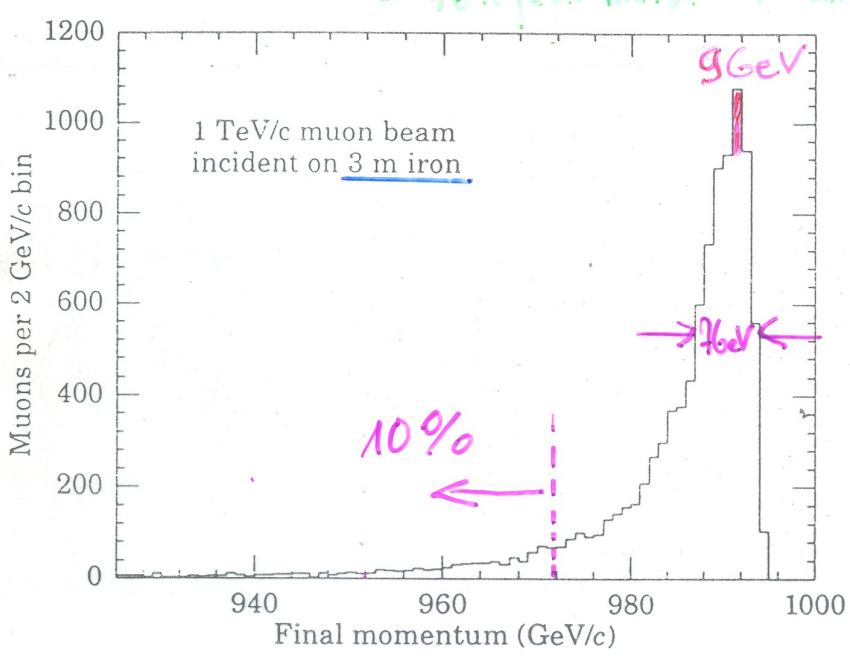


Figure 22.13: The momentum distribution of 1 TeV/c muons after traversing 3 m of iron, as obtained with Van Ginneken's TRAMU muon transport code [50].

3 m Fe ~ 18 λ_I ~ material pred
 muonskimi komorami. LHC detektorjev

1 TeV μ : ΔE_{mp} = 9 GeV (~ 1%)
 FWHM = 2 GeV (~ 1%)

rep: 10% ΔE > 28 GeV ~ zavorno sevanje
 3,3% ΔE > 100 GeV ~ fotojedrske
 ⇒ ... } + kalorimeter
 } + sledilnik !

II. Prehod fotonov skozi snov

- fotoefekt
- Comptonski pojav
- tvorba parov

razlika proti delcem

- ni energijskih izgub - $\sigma \ll \sigma_{Stli}$
- Foton izgine - "doseg" večji
- manjša se fluks

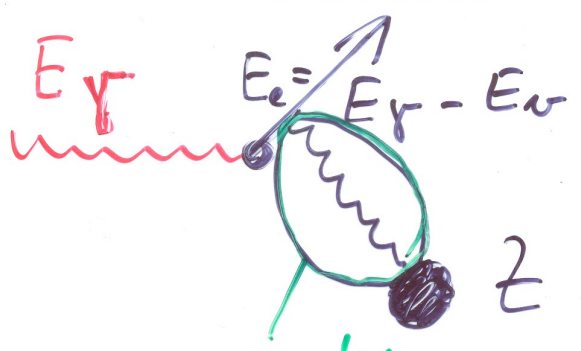
$$I = I_0 e^{-\mu x} \quad (34)$$

μ - absorpcijski koeficient

$\lambda = \frac{1}{\mu}$ - atenuacijska dolžina

a) fotoefekt

vezani elektroni v atomu



velika verjetnost le za K-elektrone

preseki narava se za $\sim Z^2$ reda, ko E_γ preseže E_v za K-elektrone - K rob

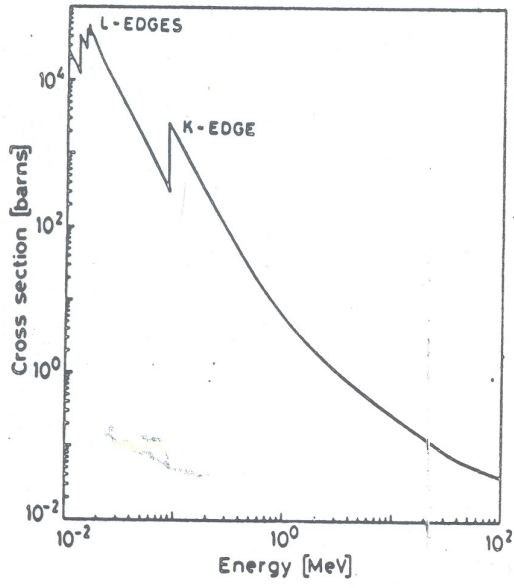


Fig. 2.21. Calculated photoelectric cross section for lead

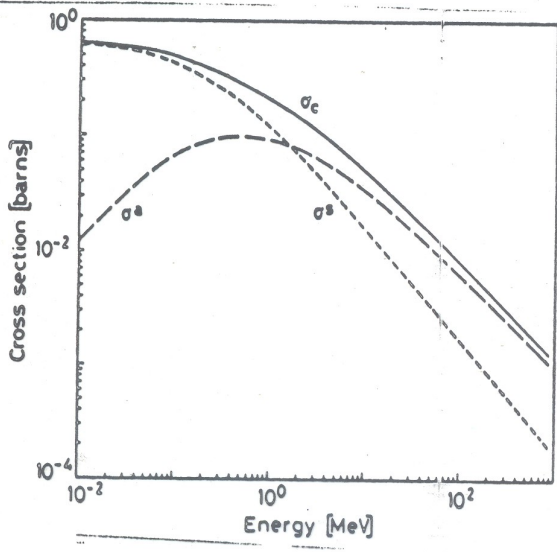


Fig. 2.23. Total Compton scattering cross sections

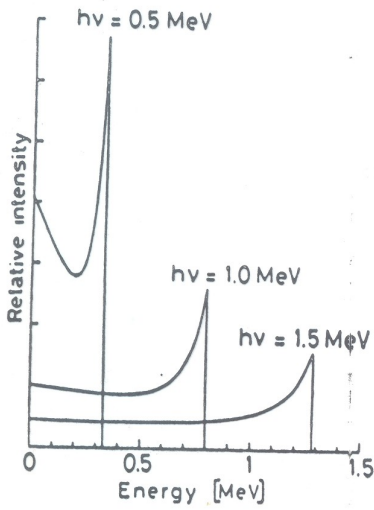


Fig. 2.24. Energy distribution of Compton recoil electrons. The sharp drop at the maximum recoil energy is known as the *Compton edge*

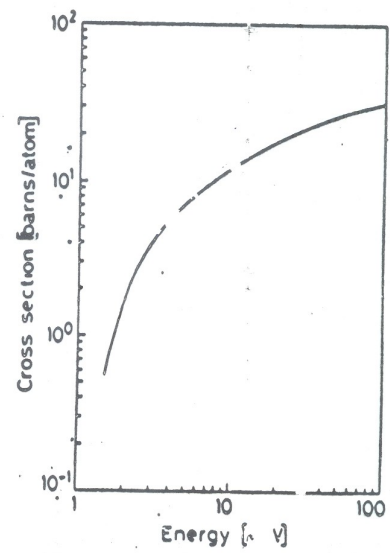


Fig. 2.25. Pair production cross section in lead

odvisnost za Γ nad K -robom

$E_K < E_F < mc^2$ nerel. račun

$$\Gamma = \frac{32\pi}{3} n_e^2 \sqrt{2} z^5 L^4 \left(\frac{mc^2}{E_F} \right)^{7/2} \approx \frac{z^5}{E_F^{7/2}} \quad (35)$$

$$\sigma_{Th} = \frac{8\pi}{3} n_e^2 = 6,65 \cdot 10^{-25} \text{ cm}^2$$

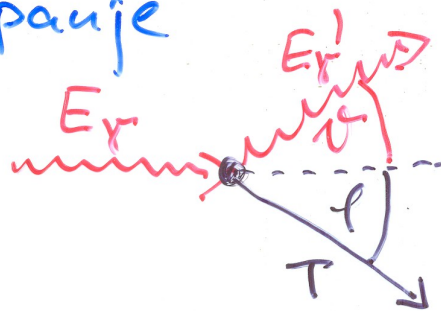
$$\Gamma = 4\sqrt{2} \sigma_{Th} z^5 L^4 \left(\frac{mc^2}{E_F} \right)^{7/2} \quad (35a)$$

$E_F \gg mc^2$ ultrarel. račun

$$\Gamma = \frac{3}{2} \sigma_{Th} z^5 L^4 \left(\frac{mc^2}{E_F} \right) \quad (36)$$

b) Comptonsko sipanje

prost elektron



$$E_F' = \frac{E_F}{1 + \gamma(1 - \cos\theta)} \quad (37)$$

$$\gamma = \frac{E_F}{mc^2}$$

$$T = E_F - E_F' = E_F \frac{\gamma(1 - \cos\theta)}{1 + \gamma(1 - \cos\theta)} \quad (38)$$

$$\frac{d\sigma}{d\Omega} = \frac{\pi e^2}{2} \frac{1}{[1 + \gamma(1 - \cos\theta)]^2} \left(1 + \cos^2\theta + \frac{\gamma^2(1 - \cos\theta)^4}{1 + \gamma(1 - \cos\theta)} \right) \quad (39)$$

Integralni presek

$$\sigma_c = 2\pi r_e^2 \left\{ \frac{1+\gamma}{\gamma^2} \left[\frac{2(1+\gamma)}{1+2\gamma} - \frac{1}{\gamma} \ln(1+2\gamma) \right] + \frac{1}{2\gamma} \ln(1+2\gamma) - \frac{1+3\gamma}{(1+2\gamma)^2} \right\} \quad (40)$$

$$\sigma_c \propto \frac{1}{E_\gamma} \quad (\text{na elektron; } \frac{Z}{E_\gamma} \text{ na atom})$$

$$\sigma_c = \sigma_s + \sigma_a ; \quad \frac{d\sigma_s}{d\Omega} = \frac{E_\gamma'}{E_\gamma} \frac{d\sigma}{d\Omega} \quad (41)$$

za velike energije : $\sigma_a \rightarrow \sigma$ (absorpcija)
 za majhne energije : $\sigma_s \rightarrow \sigma$ (sipanje)

elektroni

$$\frac{d\sigma}{d\Omega} = \frac{\pi r_e^2}{m_e c^2 \gamma^2} \left[2 + \frac{s^2}{\gamma^2(1-s)^2} + \frac{s}{1-s} \left(s - \frac{2}{\gamma} \right) \right]$$

$$s = \frac{T}{E_\gamma} ; \quad T_{\max} = E_\gamma \frac{2\gamma}{1+2\gamma} \quad \text{Comptonski rob.} \quad (42)$$

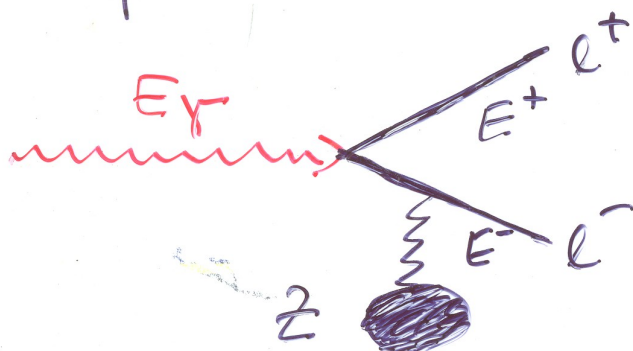
Thompson - prost elektron v klasični limiti

Rayleigh - koherentno sipanje na atomu kot celoti

 $E_f' = E_f$ elastično ; zanemarljivo za X in γ

c) tvorba parov

na jedrih - obraten proces k zavornemu sevanju



senčenje parameter $\xi = \frac{100 \text{ me}c^2 E_\gamma}{E^+ E^- Z^{1/3}}$

$$E_\gamma \gg 134 \text{ me}c^2 Z^{1/3} \rightarrow \xi \rightarrow 0$$

popolno senčenje
presek konstanten

$$\underline{\tau_p = \frac{A}{Na\rho} \frac{q}{3X_0} \propto Z^2} \quad (43)$$

$$\underline{N = N_0 e^{-\frac{2x}{3X_0}}} \quad (44)$$

elektroni vključeni v X_0 ($Z^2 \rightarrow Z(Z+1)$)

$$\lambda = \frac{9}{17} X_0$$

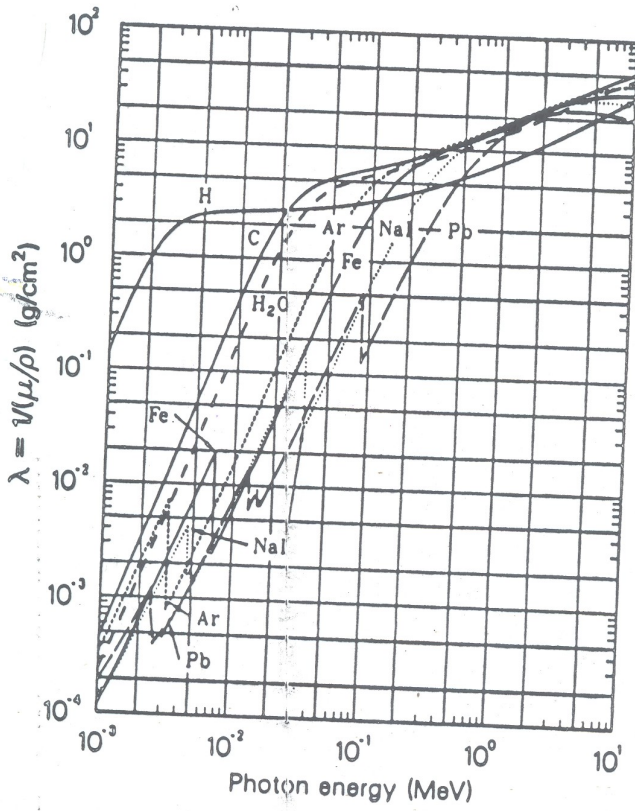
atenuacijska v radiacijska dolžina

skupaj $\underline{\tau_{tot} = \tau_{pe} + Z\tau_c + \tau_p} \quad (45)$

$$\underline{\mu = N\tau = \left(\frac{Na\rho}{A}\right)\tau} \quad (46)$$

PHOTON AND ELECTRON ATTENUATION

Photon Attenuation Length



Photon Attenuation Length (High Energy)

